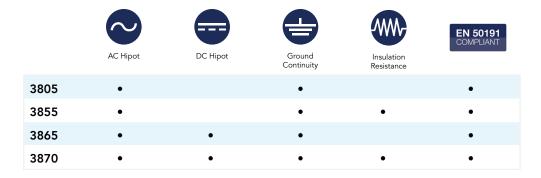


Our Hypot® Series raises the bar for production line Hipot testing. Improve traceability with onboard data storage and easily transfer test result data and test settings via convenient front panel USB. Take the guesswork out of your production line with the direct barcode connection to quickly associate products with pre-programmed test files. We've included advanced features like improved security and a touch screen interface that provides custom pop-up prompts displayed before each test step. We've dramatically reduced the weight and footprint of the Hypot® Series to make safety compliance a less strenuous ordeal. Quickly interconnect with the HYAMP® Series to form a complete safety compliance system.



## Find the Model that Fits Your Testing Needs



## SAFETY & PRODUCTIVITY FEATURES



protection





Remote Safety Interlock Easily disable HV output



Data Transfer
Easily import/
export test
files and data
via USB



Capability
Direct barcode connection



Multiple Languages Multi-Language user interface



PLC Remote Basic PLC relay control



Prompt & Hold Provides alerts & instructions between tests



Advanced User Security Customize ID & password protection



Interconnection
Interconnect with
HYAMP® to form
a complete test
system



Ramp-HI® Reduce ramp time during DC Hipot



Charge-LO® Confirms proper DUT



FailCHEK<sup>TM</sup>
Confirms
failure
detection



Accredited Cal Accredited calibration options



WithStand® Automation Software



On Board Data Storage Save up to 1,500 Test Results on-board

Voltage	INPUT SPECIFICATIONS					
DIELECTRIC WITHSTAND TEST MODE	Voltage	100 – 120 VAC / 200 – 240 VAC ± 10% Auto Range				
DIELECTRIC WITHSTAND TEST MODE	Frequency	50/60 Hz ± 5%				
Output Rating   3805/3855/ 3870   5 kVA @ 20 mAAC 6 kVA @ 7.5 mADC (3865/3870 only)	Fuse	3.15 A, Fast Blow 250 VAC				
Maximum Limit   3805/3870   AC   Range: Resolution:   0.00 – 20.00 mA   0.01 mA   DC   Range: Resolution:   Accuracy: AC and DC ± (2% of setting + 2 counts)	DIELECTRIC WITHSTAND TEST MODE					
Minimum Limit   3805/3850	Output Rating					
Resolution: Accuracy: 1 μA AC and DC ± (2% of setting ± 2 counts)	Maximum Limit		AC			
Resolution:   0.001 mA			DC	Resolution:	$^{1}\mu\text{A}$ AC and DC ± (2% of setting	
Resolution:   Accuracy:   AC   and DC ± (2% of setting + 2 counts)	Minimum Limit		AC			
Ground Fault Interrupt			DC	Resolution:	$0.1\mu A$ AC and DC ± (2% of setting	
HV Shut Down Speed: < 1 msec	Arc Detection	Range:	Range: 1 – 9 (9 is most sensitive)			
HV Shut Down Speed: < 1 msec		GFI Trip Current: 450 μA max (AC or DC), Fixed				
Range 2:   3.50 – 20.00 mA		HV Shut Down Speed: < 1 msec				
Range 2:	Current Display		AC			
+ 2 counts    DC Output Ripple   ≤ 5% Ripple rms at 6 kVDC @ 7.5 mA Resistive Load			DC	Range 2:	0.350 mA – 4.000 mA	
RAMP-HI Selectable         Range: 0.0 – 7,500 μA, User Selectable           Charge-LO         0 – 350 μA DC or Auto Set           Discharge Time         < 50 msec for no load, < 100 msec for capacitive load The maximum capacitive load vs. output voltage: 1μF < 1KV 0.08μF < 4KV 0.75μF < 2KV 0.04μF < 5KV 0.5μF < 3KV 0.015uF < 6KV           AC Voltage Waveform/ Frequency         Sine Wave, Crest Factor = 1.3 – 1.5           Range:         50 or 60 Hz, User Selectable           Dwell Timer         Range: AC 0, 0.2-999.9 sec (0=Continuous) DC 0, 0.4-999.9 sec (0=Continuous)           Ramp Timer         Range: Ramp-Up: 0.1 – 999.9 sec Ramp-Down: AC 0.0 – 999.9 sec DC 0, 1.0 – 999.9 sec, (0=OFF)				Accuracy:		
	DC Output Ripple	$\leq$ 5% Ripple rms at 6 kVDC @ 7.5 mA Resistive Load				
		Range: $0.0 - 7,500~\mu\text{A}$ , User Selectable				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Charge-LO	$0-350~\mu\text{A}$ DC or Auto Set				
Waveform/ Frequency         Range:         50 or 60 Hz, User Selectable           Dwell Timer         Range:         AC 0, 0.2-999.9 sec (0=Continuous) DC 0, 0.4-999.9 sec (0=Continuous)           Ramp Timer         Range:         Ramp-Up: 0.1 – 999.9 sec Ramp-Down: AC 0.0 – 999.9 sec DC 0, 1.0 – 999.9 sec, (0=OFF)	Discharge Time	The maximum capacitive load vs. output voltage: $1\mu F < 1KV \qquad 0.08\mu F < 4KV \\ 0.75\mu F < 2KV \qquad 0.04\mu F < 5KV$				
Frequency         Range:         50 or 60 Hz, User Selectable           Dwell Timer         Range:         AC 0, 0.2-999.9 sec (0=Continuous) DC 0, 0.4-999.9 sec (0=Continuous)           Ramp Timer         Ramp-Up: 0.1 – 999.9 sec Ramp-Down: AC 0.0 – 999.9 sec DC 0, 1.0 – 999.9 sec, (0=OFF)		Sine Wave, Crest Factor = 1.3 – 1.5				
DC 0, 0.4-999.9 sec (0=Continuous)  Ramp Timer  Ramp-Up: 0.1 – 999.9 sec Ramp-Down: AC 0.0 – 999.9 sec DC 0, 1.0 – 999.9 sec, (0=OFF)		Range: 50 or 60 Hz, User Selectable				
Ramp-Down: AC 0.0 – 999.9 sec DC 0, 1.0 – 999.9 sec, (0=OFF)	Dwell Timer	Range:				
Ground Continuity DC 0.1A ± 0.01 A. fixed	Ramp Timer	Ramp-Down: AC 0.0 – 999.9 sec				
Current	Ground Continuity Current	DC 0.1A ± 0.01 A, fixed				
	Maximum Limit	Resolution:	0.01 Ω			
$ \begin{array}{c c} \textbf{Ground Continuity} & Range: & 0.00-0.50 \ \Omega \\ \textbf{Auto Offset} & Resolution: & 0.01 \ \Omega \\ & Accuracy: & \pm (3\% \ of \ setting + 0.02 \ \Omega) \\ \end{array} $		Resolution:	0.01 Ω			

INSULATION RESISTANCE TEST MODE				
Voltage Setting	Range: Resolution:	30 – 1,000 VDC 1 V		
	Accuracy:	± (2% of setting + 5 V)		
Resistance Display	Range:	1 – 50,000 ΜΩ		
	$\begin{tabular}{lll} Resolution: & 30-99 \ VI \\ M\Omega & M\Omega \\ 0.001 & 1.000-1.9 \\ 0.01 & 2.00-19.9 \\ 0.1 & 200-10.0 \\ \end{tabular}$	$\begin{array}{cccc} & M\Omega & M\Omega \\ P99 & 1.000 - 1.999 & 1.000 - 9.999 \\ P9 & 2.00 - 19.99 & 10.00 - 99.99 \\ P9 & 20.0 - 199.9 & 100.0 - 999.9 \\ \end{array}$		
	Accuracy:	± (8% of reading+2 counts) at test voltage 30 – 499 V and 1.00–999.9 MΩ		
	At test voltage 500-1000 V $\pm$ (2% of reading + 2 counts) for 1.00 – 999.9 M $\Omega$ $\pm$ (5% of reading + 2 counts) for 1000 – 9999 M $\Omega$ $\pm$ (15% of reading + 2 counts) for 10000 – 50,000 M $\Omega$			
HI & LO-Limit	Range: Resolution:	0, 1.00 – 99.99 M $\Omega$ (0=OFF, HI-Limit ONLY) 0.01 M $\Omega$ 1000-50000 1 M $\Omega$		
	Range: Resolution:	100.0 – 999.9 MΩ 0.1 MΩ		
	Accuracy:	At test voltage 500-1000 V $\pm$ (2% of setting + 2 counts) for 1.00 – 999.9 M $\Omega$ $\pm$ (5% of setting + 2 counts) for 1000 – 9999 M $\Omega$ $\pm$ (15% of setting + 2 counts) for 10000 – 50,000 M $\Omega$		
Charge-LO	Range:	0.000 – 3.500 μA DC or Auto Set		
Ramp Timer	Range:	Ramp-Up: 0.1 – 999.9 sec Ramp-Down: 0, 1.0 – 999.9 sec, (0=OFF)		
Delay Timer	Range:	0.5 – 999.9 sec (0=OFF)		
Dwell Timer	Range:	0, 0.5 – 999.9 sec (0=continuous)		
GENERAL SPECIFICATIONS				
Remote Control and Signal I/O	Inputs: Test, Reset, Hardware Interlock, File Recall Outputs: Pass, Fail, Test-in-Process, Reset-Out, Start-Out			
Vmax	Displays the maximum voltage value recorded during a breakdown			
lmax	Displays the maximum leakage current value read during a test			
Memories	50 steps 1500 test results			
Interface	USB standard			
Language	English, Traditional Chinese, Simplified Chinese, Turkish, Portuguese, Spanish, German, French			
Security	Multiple user setups with ID and password			
Dimensions (W x H x D)	3805/3855/ 8.5" x 3.5" x 11.9" 3865/3870 (215 mm x 88.1 mm x 300 mm)			
Weight	3805/3855/ 3865/3870	12 lbs (5.46 kgs)		

Why We Use Counts
Associated Research publishes some specifications using "counts" which allows us to provide a better indication of the instrument's capabilities across measurement ranges. A count refers to the lowest resolution of the display for a given measurement range. For example, if the resolution for voltage is 1V then 2 counts = 2 V.

3865/3870

 ${\bf Specifications\ subject\ to\ change\ without\ notice.}$ 

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